Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10600014	CHATTERJEE ET AL.
Examiner	Art Unit

2166

SEARCHED				
Class	Subclass	Date	Examiner	

Lin, Shew-Fen

SEARCH NOTES			
Search Notes	Date	Examiner	
East	12/1/2007	SFL	
Consult Khanh Pham (Primary Examiner 2166)	12/3/2007	SFL	
East text search	7/16/08-7/17/08	SFL	

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